

Dual P-Channel 30 V (D-S) MOSFET

| PRODUCT SUMMARY | | | |
|---------------------|------------------------------------|--------------------|-----------------------|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) | Q _g (Typ.) |
| - 30 | 0.054 at V _{GS} = - 10 V | - 6 ^a | 4.8 nC |
| | 0.088 at V _{GS} = - 4.5 V | - 6 ^a | |

FEATURES

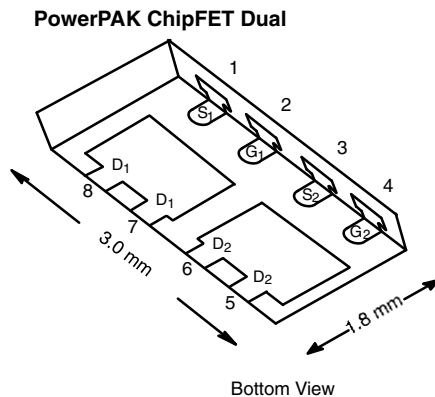
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm Profile
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC



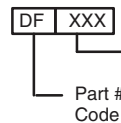
RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

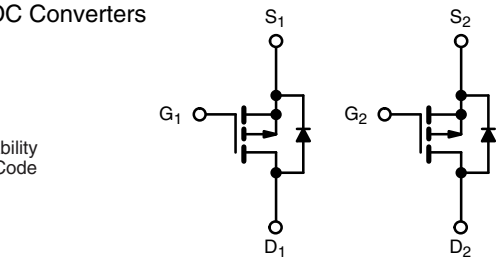
- Load Switch for Portable Devices
- DC/DC Converters



Marking Code



Lot Traceability and Date Code



P-Channel MOSFET P-Channel MOSFET

Ordering Information: Si5997DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted) | | | |
|---|-----------------------------------|------------------------|-----------------------|
| Parameter | Symbol | Limit | Unit |
| Drain-Source Voltage | V _{DS} | - 30 | V |
| Gate-Source Voltage | V _{GS} | ± 20 | |
| Continuous Drain Current (T _J = 150 °C) | I _D | T _C = 25 °C | - 6 ^a |
| | | T _C = 70 °C | - 6 ^a |
| | | T _A = 25 °C | - 5.1 ^{b, c} |
| | | T _A = 70 °C | - 4.1 ^{b, c} |
| Pulsed Drain Current (t = 300 μs) | I _{DM} | - 25 | A |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | |
| | | T _A = 25 °C | - 1.9 ^{b, c} |
| Maximum Power Dissipation | P _D | T _C = 25 °C | 10.4 |
| | | T _C = 70 °C | 6.7 |
| | | T _A = 25 °C | 2.3 ^{b, c} |
| | | T _A = 70 °C | 1.5 ^{b, c} |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | - 55 to 150 | °C |
| Soldering Recommendations (Peak Temperature) ^{d, e} | | 260 | |

| THERMAL RESISTANCE RATINGS | | | | |
|---|-------------------|---------|---------|------|
| Parameter | Symbol | Typical | Maximum | Unit |
| Maximum Junction-to-Ambient ^{b, f} | R _{thJA} | 43 | 55 | °C/W |
| Maximum Junction-to-Case (Drain) | R _{thJC} | 9.5 | 12 | |

Notes:

- Package limited.
- Surface mounted on 1" x 1" FR4 board.
- t = 5 s.
- See solder profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under steady state conditions is 105 °C/W.

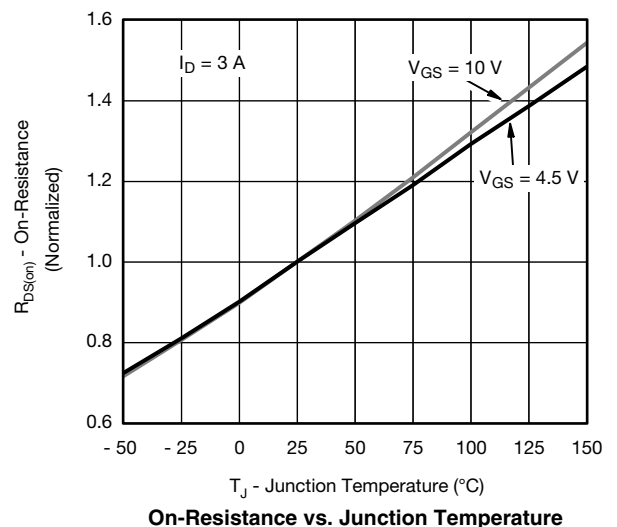
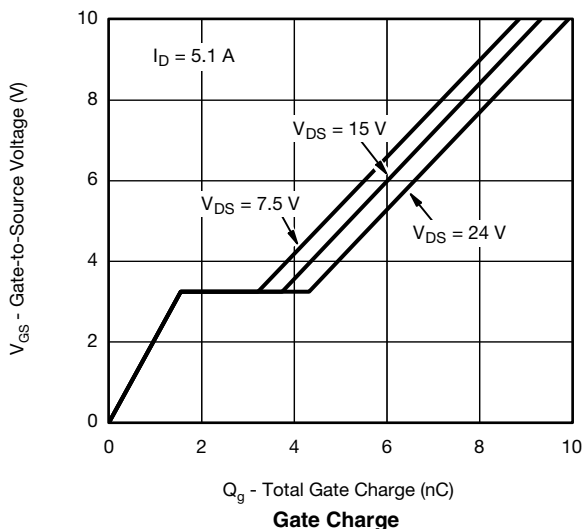
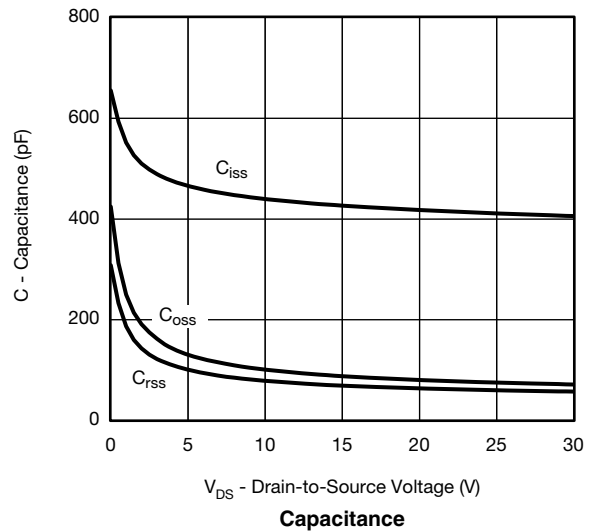
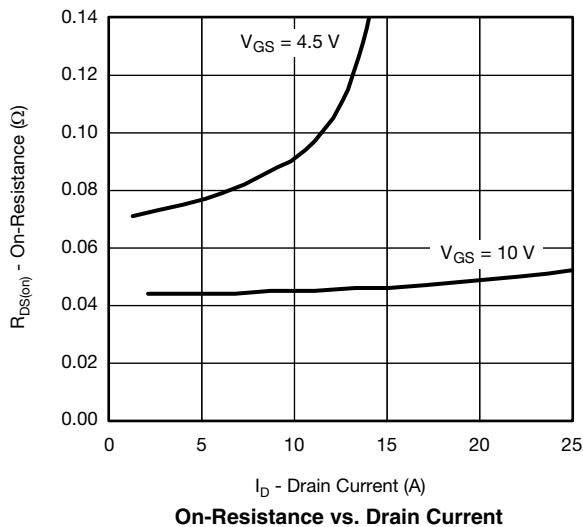
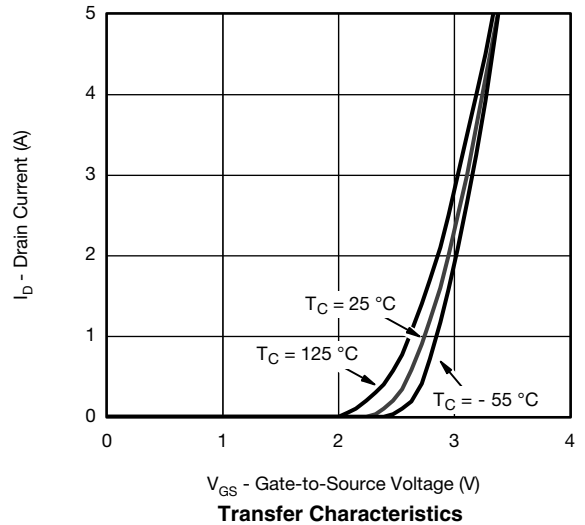
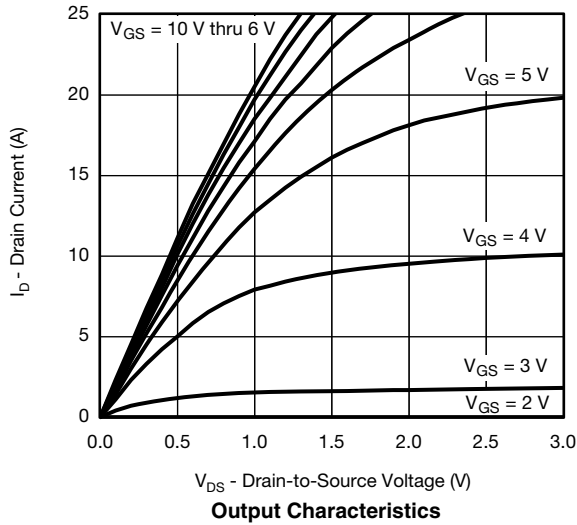
| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | |
|--|-------------------------|---|------|-------|-----------|----------------------|
| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$ | -30 | | | V |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | $I_D = -250\text{ }\mu\text{A}$ | | -22 | | mV/ $^\circ\text{C}$ |
| $V_{GS(th)}$ Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | | 4.1 | | | |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$ | -1.2 | | -2.4 | V |
| Gate-Source Leakage | I_{GSS} | $V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = -30\text{ V}, V_{GS} = 0\text{ V}$ | | | -1 | μA |
| | | $V_{DS} = -30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$ | | | -10 | |
| On-State Drain Current ^a | $I_{D(on)}$ | $V_{DS} \leq -5\text{ V}, V_{GS} = -10\text{ V}$ | -20 | | | A |
| Drain-Source On-State Resistance ^a | $R_{DS(on)}$ | $V_{GS} = -10\text{ V}, I_D = -3\text{ A}$ | | 0.045 | 0.054 | Ω |
| | | $V_{GS} = -4.5\text{ V}, I_D = -1\text{ A}$ | | 0.072 | 0.088 | |
| Forward Transconductance ^a | g_{fs} | $V_{DS} = -15\text{ V}, I_D = -3\text{ A}$ | | 7 | | S |
| Dynamic^b | | | | | | |
| Input Capacitance | C_{iss} | $V_{DS} = -15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | | 430 | | pF |
| Output Capacitance | C_{oss} | | 90 | | | |
| Reverse Transfer Capacitance | C_{rss} | | 70 | | | |
| Total Gate Charge | Q_g | $V_{DS} = -15\text{ V}, V_{GS} = -10\text{ V}, I_D = -5.1\text{ A}$ | | 9.5 | 14.5 | nC |
| | | | | 4.8 | 7.5 | |
| Gate-Source Charge | Q_{gs} | $V_{DS} = -15\text{ V}, V_{GS} = -4.5\text{ V}, I_D = -5.1\text{ A}$ | | 1.6 | | |
| Gate-Drain Charge | Q_{gd} | | 2.2 | | | |
| Gate Resistance | R_g | $f = 1\text{ MHz}$ | 2 | 8 | 16 | Ω |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = -15\text{ V}, R_L = 3.7\text{ }\Omega$ $I_D \cong -4.1\text{ A}, V_{GEN} = -4.5\text{ V}, R_g = 1\text{ }\Omega$ | | 35 | 70 | ns |
| Rise Time | t_r | | 25 | 50 | | |
| Turn-Off Delay Time | $t_{d(off)}$ | | 17 | 35 | | |
| Fall Time | t_f | | 10 | 20 | | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = -15\text{ V}, R_L = 3.7\text{ }\Omega$ $I_D \cong -4.1\text{ A}, V_{GEN} = -10\text{ V}, R_g = 1\text{ }\Omega$ | | 10 | 20 | |
| Rise Time | t_r | | 10 | 20 | | |
| Turn-Off Delay Time | $t_{d(off)}$ | | 20 | 40 | | |
| Fall Time | t_f | | 10 | 20 | | |
| Drain-Source Body Diode Characteristics | | | | | | |
| Continuous Source-Drain Diode Current | I_S | $T_C = 25\text{ }^\circ\text{C}$ | | | -6 | A |
| Pulse Diode Forward Current | I_{SM} | | | | -25 | |
| Body Diode Voltage | V_{SD} | $I_S = -4.1\text{ A}, V_{GS} = 0\text{ V}$ | | -0.85 | -1.2 | V |
| Body Diode Reverse Recovery Time | t_{rr} | $I_F = -4\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$ | | 15 | 30 | ns |
| Body Diode Reverse Recovery Charge | Q_{rr} | | 8 | 15 | nC | |
| Reverse Recovery Fall Time | t_a | | 10.5 | | ns | |
| Reverse Recovery Rise Time | t_b | | 4.5 | | | |

Notes:

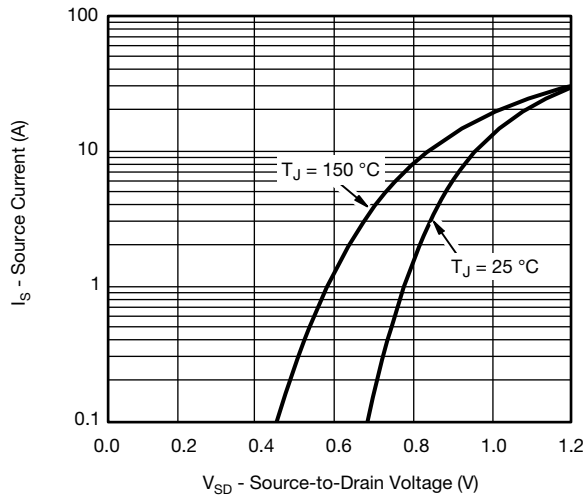
- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

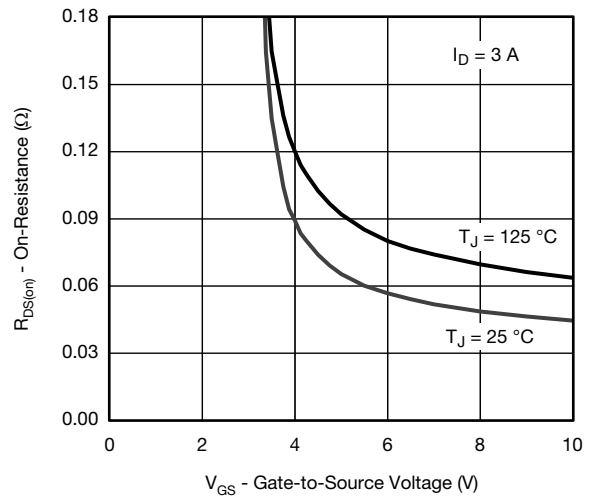
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



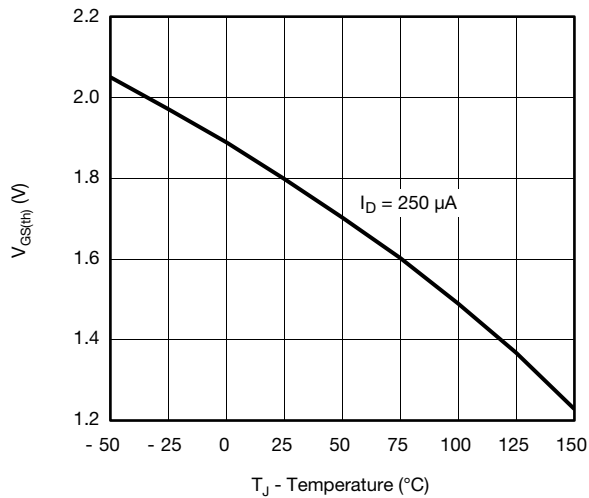
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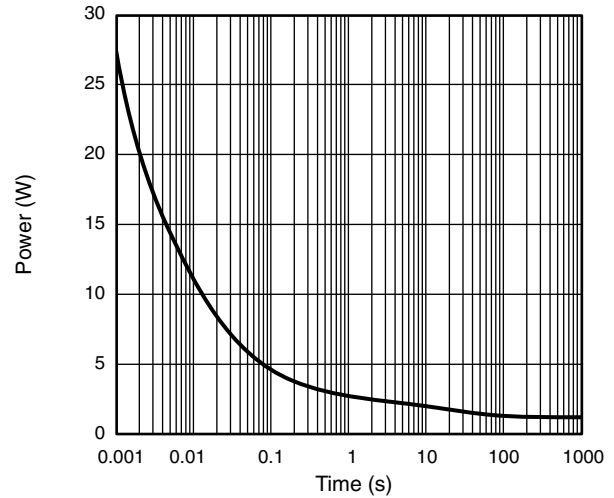
Source-Drain Diode Forward Voltage



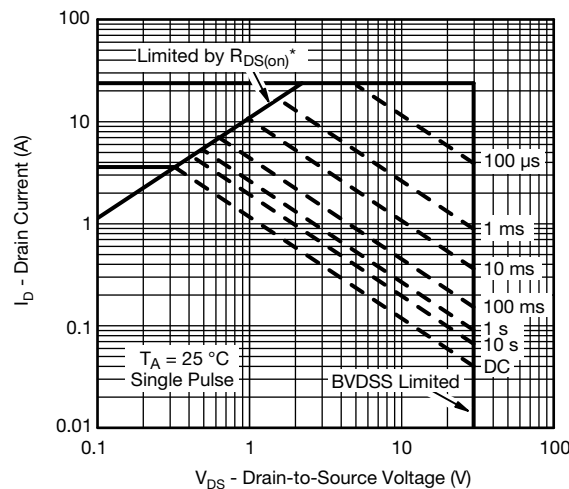
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



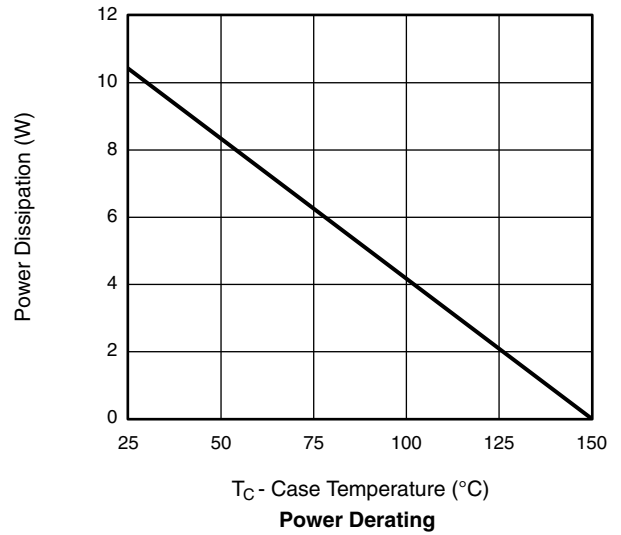
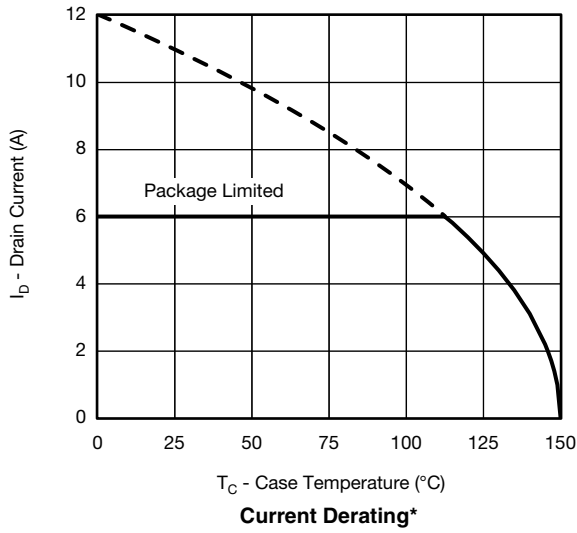
Single Pulse Power, Junction-to-Ambient



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

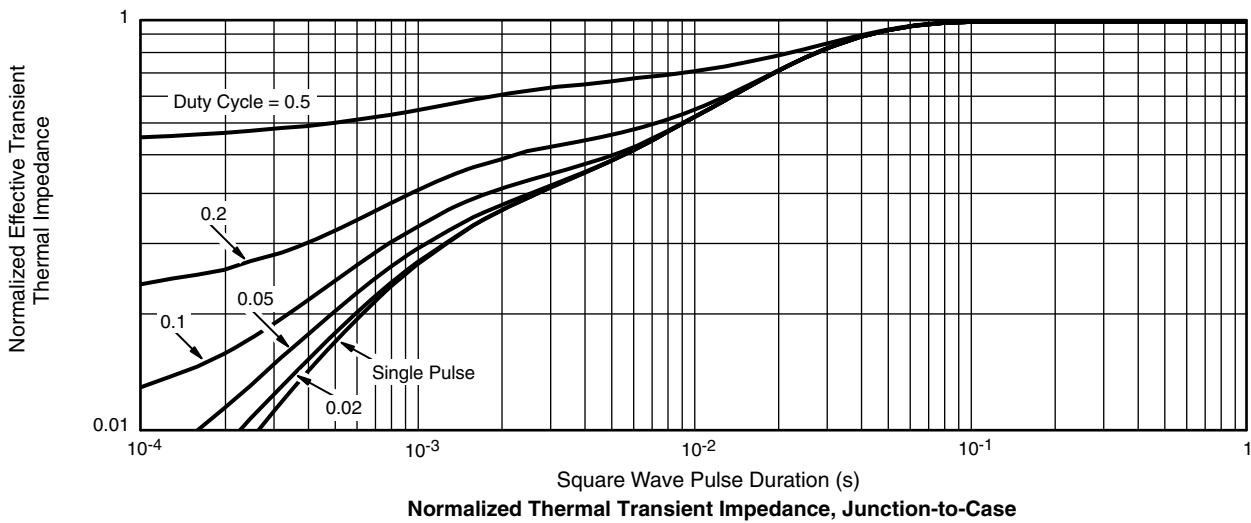
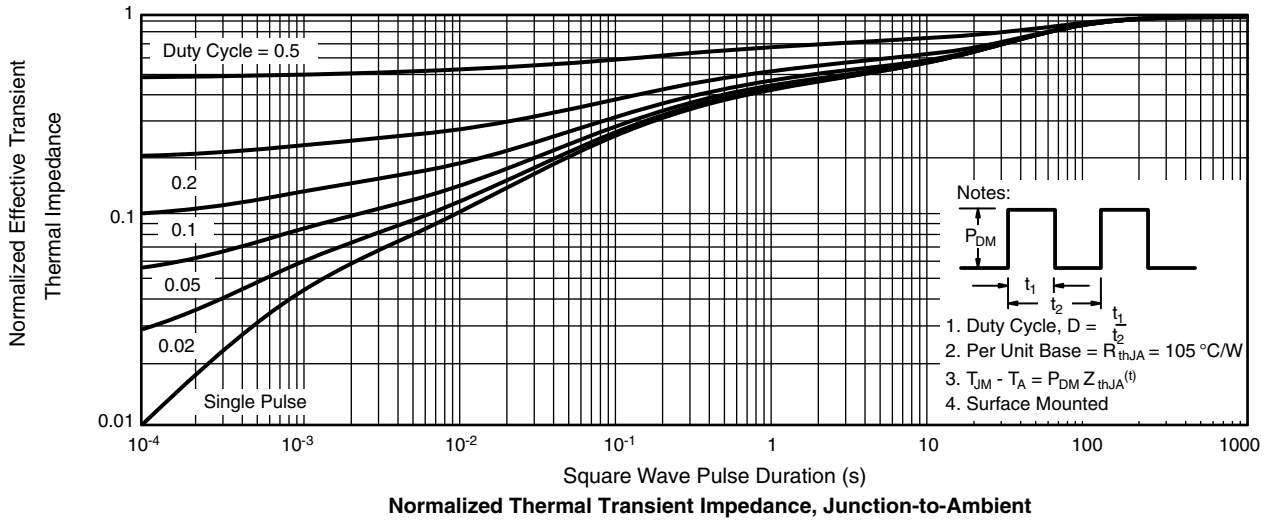
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?267186.

PowerPAK® ChipFET® Case Outline



| DIM. | MILLIMETERS | | | INCHES | | |
|------|-------------|------|------|-----------|-------|-------|
| | MIN. | NOM. | MAX. | MIN. | NOM. | MAX. |
| A | 0.70 | 0.75 | 0.85 | 0.028 | 0.030 | 0.033 |
| A1 | 0 | - | 0.05 | 0 | - | 0.002 |
| b | 0.25 | 0.30 | 0.35 | 0.010 | 0.012 | 0.014 |
| C | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| D | 2.92 | 3.00 | 3.08 | 0.115 | 0.118 | 0.121 |
| D1 | 1.75 | 1.87 | 2.00 | 0.069 | 0.074 | 0.079 |
| D2 | 1.07 | 1.20 | 1.32 | 0.042 | 0.047 | 0.052 |
| D3 | 0.20 | 0.25 | 0.30 | 0.008 | 0.010 | 0.012 |
| E | 1.82 | 1.90 | 1.98 | 0.072 | 0.075 | 0.078 |
| E1 | 1.38 | 1.50 | 1.63 | 0.054 | 0.059 | 0.064 |
| E2 | 0.92 | 1.05 | 1.17 | 0.036 | 0.041 | 0.046 |
| E3 | 0.45 | 0.50 | 0.55 | 0.018 | 0.020 | 0.022 |
| e | 0.65 BSC | | | 0.026 BSC | | |
| H | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| K | 0.25 | - | - | 0.010 | - | - |
| K1 | 0.30 | - | - | 0.012 | - | - |
| K2 | 0.20 | - | - | 0.008 | - | - |
| K3 | 0.20 | - | - | 0.008 | - | - |
| L | 0.30 | 0.35 | 0.40 | 0.012 | 0.014 | 0.016 |

C14-0630-Rev. E, 21-Jul-14
DWG: 5940

Note

- Millimeters will govern

RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Dual



Recommended Minimum Pads
Dimensions in mm/(Inches)

Note: This is Flipped Mirror Image
Pin #1 Location is Top Left Corner



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